

## Short Communication

---

### Schottky diodes based on poly(*p*-phenylene) and poly(1,4-dipyrrolobenzene)

I. B. Nazarova, V. I. Krinichnyi\* and L. M. Goldenberg

*Institute of Chemical Physics, Russian Academy of Sciences, Chernogolovka,  
142432 Moscow Region (Russian Federation)*

(Received July 11, 1992; accepted in revised form September 1, 1992)

#### Abstract

Current–voltage characteristics of a sandwich-type device based on poly(*p*-phenylene) and poly(1,4-dipyrrolobenzene) films are investigated. The characteristics depend on the type of polymer and on the sample conductivity. Poly(*p*-phenylene) with a conductivity  $10^{-3}$ – $10^{-5}$  S/cm yields Schottky-type junctions with In and Pb. The device parameters are evaluated from current–voltage characteristics.

#### Introduction

Organic semiconductors have attracted much interest due to their possible application as basic materials in molecular microelectronic devices, such as diodes, transistors, sensors, etc. (see, e.g. [1–3]).

In particular organic polymers can be potentially used as semiconductive materials in solar cells [1–4]; they may be produced on the basis of a Schottky barrier diode between semiconductors and various metals having an appropriate work function. Such devices were initially constructed using thin films of *trans*-polyacetylene, polythiophene or polypyrrole [5, 6]. Recently, we have reported [7] the fabrication of a Schottky barrier on the basis of a sandwich-type element Pt/poly(*p*-phenylene)/In. Free poly(*p*-phenylene) (PPP) films were synthesized by benzene electropolymerization (EP) on a Ti electrode.

In this work we report the studies on Schottky barriers involving poly(1,4-dipyrrolobenzene) (PDPB) and PPP synthesized by EP of biphenyl.

#### Experimental

PPP films were obtained by the EP of biphenyl in  $\text{CH}_2\text{Cl}_2$ – $\text{Bu}_4\text{NBF}_4$ –oleum solution on a Pt electrode at a constant current of 1 mA/cm<sup>2</sup> similar to

---

\*Author to whom correspondence should be addressed.

of the secondary electrons from an organic semiconductor. This phenomenon was not observed for PPP films with a considerably lower conductivity.

Semilogarithmic plots of the forward current densities versus forward voltage for PDPB, PPP-I and PPP-II elements are presented in Fig. 2(a). The above  $I-U$  characteristics for PPP-I and PPP-II diodes have an exponential dependence following eqn. (1) up to  $U_F = 1$  V, while that of PDPB have this dependence only up to about 0.6 V. This indicates that device resistances of PPP-I and PPP-II (unlike PDPB) are not higher than the combination of a polymer bulk resistance, a barrier In or Pb electrode sheet resistance due to the back-ohmic contact.

From the extrapolation of the linear part of the plots to zero bias voltage, the saturation current values  $I_0^F$  and the quality factor  $n$  for all these devices were estimated (Table 1). Note, that the quality factor  $n$ , determined from eqn. (1), is essentially higher than unity, whereas this value for the ideal diode must be equal to unity. Using the value of  $A = 120 \text{ A/(K}^2 \text{ cm}^2)$ , the barrier heights were determined at room temperature from eqn. (2) (see Table 1).

In order to specify the saturation current density  $I_0$ , the semilogarithmic plot of the reverse current density versus reverse voltage was used. Figure 2(b) shows the semilogarithmic plots of reverse current densities versus  $(U_C - U_R)^{0.25}$ . Using the theoretical value  $U_C = 1.48$  V for PPP [11] and extrapolating the plots to zero bias voltage, the saturation current density values  $I_0^R$  were

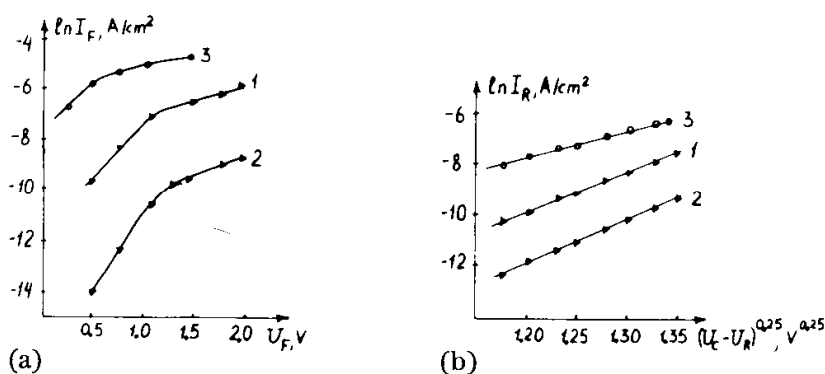


Fig. 2. Semilogarithmic plots of current density vs. (a)  $U_F$  and (b)  $(U_C - U_R)^{0.25}$  for (1) Pt/PPP/In, (2) Pt/PPP/Pb and (3) Pt/PDPB/In devices.

TABLE 1

Saturation current density  $I_0$ , barrier height  $\Phi_B$  and quality factor  $n$  for devices based on PPP and PDPB films

Sample	$I_0^F$ ( $\text{A/cm}^2$ ) <sup>a</sup>	$I_0^R$ ( $\text{A/cm}^2$ ) <sup>a</sup>	$\Phi_B$ (eV)	$n$
PDPB	$5.0 \times 10^{-4}$	$2.2 \times 10^{-4}$	0.61	8.4
PPP-I	$0.78 \times 10^{-5}$	$1.0 \times 10^{-5}$	0.70	8.6
PPP-II	$0.68 \times 10^{-7}$	$2.8 \times 10^{-7}$	0.82	7.1

<sup>a</sup> $I_0^F$  and  $I_0^R$  values were determined using the data of Fig. 2(a) and 2(b), respectively.

estimated from the following relationship [10]:

$$\ln I_0^R = K_S(U_C - U_R)^{0.25} \quad (3)$$

where  $K_S$  is the coefficient,  $U_C$  and  $U_R$  are the contact and reverse potentials, respectively (Table 1). The values of  $I_0^R$  and  $I_0^F$  for all devices do not differ greatly. This fact demonstrates that the interpretation of the data obtained is coherent with the classical one for the Schottky barriers.

## Conclusions

It has been observed that the constructed diodes have asymmetrical, strongly non-ohmic characteristics. The devices constructed with the PPP films have better characteristics because biphenyl was used as a monomer.

The experimental data enable further development of Schottky elements by varying the polymers and synthetic conditions. Further improvements of the Schottky device characteristics can be achieved by the use of thinner PPP films of higher quality with intermediate conductivity values.

## Acknowledgements

The authors express their sincere gratitude to Dr O. N. Efimov for his sustained attention to this work.

## References

- 1 T. A. Skotheim (ed.), *Handbook of Conducting Polymers*, Vols. 1 and 2, Marcel Dekker, New York, 1986.
- 2 S. Gleins and A. J. Frank, *Synth. Met.*, 28 (1989) C681.
- 3 H. Kuzmany, M. Mehring and S. Roth (eds.), *Electronic Properties of Polymers and Related Compounds*, Springer Series in Solid State Sciences, Vols. 63 and 76, Springer, Berlin, 1985–1989.
- 4 A. Boyle, E. M. Geniès and M. Łapkowski, *Synth. Met.*, 28 (1989) C769.
- 5 J. Kanicki, in T. A. Skotheim (ed.), *Handbook of Conducting Polymers*, Vol. 1, Marcel Dekker, New York, 1986, p. 543.
- 6 J. Unsworth, Z. Jin, B. A. Lunn and P. C. Junis, *Polym. Int.*, 26 (1991) 245.
- 7 L. M. Goldenberg, V. I. Krinichnyi and I. B. Nazarova, *Synth. Met.*, 44 (1991) 199.
- 8 L. M. Goldenberg, I. B. Nazarova, O. N. Efimov, R. N. Lyubovskaya, O. S. Roschupkina and A. N. Titkov, *Synth. Met.*, 44 (1991) 133.
- 9 L. M. Goldenberg, R. N. Lyubovskaya, I. B. Nazarova and O. S. Roschupkina, *Synth. Met.*, 40 (1991) 393.
- 10 E. H. Rhoderick, *Metal–Semiconductor Contacts*, Clarendon Press, Oxford, 1980.
- 11 J. L. Brédas, in T. A. Skotheim (ed.), *Handbook of Conducting Polymers*, Vol. 1, Marcel Dekker, New York, 1986, p. 869.